MN101C70C

Туре	MN101C70C MN101CF70D		
Internal ROM type	Mask ROM	FLASH	
ROM (byte)	48K	64K	
RAM (byte)	2K	4K	
Package (Lead-free)	LQFP080-P-1414A, TQFP080-P-1212D (Under planning)	LQFP080-P-1414A (Under development), TQFP080-P-1212D (Under planning)	
Minimum Instruction Execution Time	0.1 μs (at 3.0 V to 3.6 V, 10 MHz) 0.235 μs (at 1.8 V to 3.6 V, 4.25 MHz) 62.5 μs (at 1.8 V to 3.6 V, 32 kHz)	0.25 µs (at 3.0 V to 3.6 V, 8 MHz) 0.50 µs (at 2.28 V to 3.6 V, 4 MHz) 62.5 µs (at 2.2 V to 3.6 V, 32 kHz)	

Interrupts

RESET, Watchdog, External 0 to 2, External 4 (key interrupt dedicated), Timer 0 to 3, Timer 6, Timer 7 (2 systems), Timer 8 (2 systems), Time base, Serial 0 (2 systems), Serial 2, A/D conversion finish, Automatic transfer finish

Timer Counter

Timer counter 0 : 8-bit \times 1

(square-wave/8-bit PWM output, event count, generation of remote control carrier, simple pulse width measurement, added pluse

(2-bit) system PWM output, real time output control)

(square-wave/PWM output to large current terminal P50 possible)

Interrupt source coincidence with compare register 0

Timer counter 1 : 8-bit \times 1

(square-wave output, event count, synchronous output event, serial transfer clock output)

Clock source...... 1/2, 1/8 of system clock frequency; 1/1, 1/4, 1/16, 1/64, 1/128 of OSC oscillation clock frequency; 1/1 of XI oscillation clock frequency; external clock input

Interrupt source coincidence with compare register 1

Timer counter 0, 1 can be cascade-connected.

Timer counter 2 : 8-bit \times 1

(square-wave output, added pluse (2-bit) system PWM output, PWM output, serial transfer clock output, real time output control, event count, synchronous output event, simple pulse width measurement)

(square-wave/PWM output to large current terminal P52 possible)

Clock source...... 1/2, 1/4 of system clock frequency; 1/1, 1/4, 1/16, 1/32, 1/64 of OSC oscillation clock frequency; 1/1 of XI oscillation clock frequency; external clock input

Interrupt source coincidence with compare register 2

Timer counter 3 : 8-bit \times 1

(square-wave output, event count, generation of remote control carrier, serial transfer clock)

Clock source...... 1/2, 1/8 of system clock frequency; 1/1, 1/4, 1/16, 1/64, 1/128 of OSC oscillation clock frequency; 1/1 of XI oscillation clock frequency; external clock input

Interrupt source coincidence with compare register 3

Timer counter 2, 3 can be cascade-connected.

Timer counter 6 : 8-bit freerun timer

Clock source...... 1/1 of system clock frequency; 1/1, 1/128, 1/8192 of OSC oscillation clock frequency; 1/1, 1/128, 1/8192 of XI oscillation clock frequency

Interrupt source coincidence with compare register 6

Timer counter 7 : 16-bit \times 1

(square-wave output, 16-bit PWM output (cycle / duty continuous variable), event count, synchronous output event, pulse width measurement, input capture, real time output control, high performance IGBT output (Cycle/Duty can be changed constantly))

(square-wave/PWM output to large current terminal P51 possible)

Clock source...... 1/1, 1/2, 1/4, 1/16 of system clock frequency; 1/1, 1/2, 1/4, 1/16 of OSC oscillation clock frequency; 1/1, 1/2, 1/4, 1/16 of external clock input frequency

Interrupt source coincidence with compare register 7 (2 lines), input capture register

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Timer counter 8 :	16 bit × 1							
(square-wave/1	6-bit PWM		y continuous variable], event count, pulse width meas	surement, input				
		-	large current terminal P53 possible) 16 of system clock frequency; 1/1, 1/2, 1/4, 1/16 of OSC os	adultion algoly fraguen				
Clock source			External clock input frequency	scillation clock irequent	cy; 1/1,			
Interrupt source			h compare register 8 (2 lines), input capture register					
Timer counters 7	8 can be c	ascade-co	nnected. (square-wave output, PWM is possible as a	32-bit timer.)				
Time base timer (one-minute	e count sett	ing)					
			cillation clock frequency; 1/1 of XI oscillation clock frequency					
Interrupt source	e 1/12	28, 1/256, 1/	512, 1/1024, 1/8192, 1/32768, of clock source frequency					
Watchdog timer								
Interrupt source	e 1/65	5536, 1/2621	44, 1/1048576 of system clock frequency					
Serial interface								
Serial 0 : synchro	• •							
Clock source		-	em clock frequency; pulse output of timer counter 2 or 3; 1/ c frequency, external clock	'2, 1/4, 1/16, 1/64 of OS	SC			
Serial 2 : synchro	nous type/s	single-mast	ter I ² C \times 1					
Clock source		-	m clock frequency; pulse output of timer counter 2 or 3; 1/ c frequency, external clock	'2, 1/4, 1/16, 1/32 of OS	SC			
Transfer mode : 1-1	-	-	pes of interrupt, software fer, burst transfer					
1/0	66	Commo	n use Specified null un register queilable Innut/outnut as	lastable (bit unit)				
1/0	00	Commo	n use, Specified pull-up resistor available, Input/output se	lectable (bit unit)				
A/D converter 10-bit × 16-ch. (wi	th S/H)							
Display control fun	ction							
LCD								
32 segments \times 4 co			• /					
	-		sable if VDD \leq VLCD \leq 3.6 V)					
LCD power step-up LCD power shunt i			2 and 3 times)					
LCD reference vol								
Special Ports								
	ote control c	carrier signa	l output, high-current drive port					
ROM Correction								
Correcting address	designation	: up to 3 add	dresses possible					
Electrical Charactro	eistics (Su	pply curre	ent)					
		0	0	Limit				

Parameter	Symbol	Condition	Limit			Unit
- arameter			min	typ	max	Unit
Operating supply current	IDD1	fosc = 4 MHz, $VDD = 3 V$		1	1.8	mA
	IDD2	fx = 32 kHz, $VDD = 3 V$		4	15	μΑ
Supply current at HALT	IDD3	$fx = 32 \text{ kHz}$, $VDD = 3 \text{ V}$, $Ta = 25^{\circ}C$		2	5	μΑ
	IDD4	fx = 32 kHz , VDD = 3 V , Ta = -40° C to $+85^{\circ}$ C			10	μΑ
Supply current at STOP	IDD5	$VDD = 3 V$, $Ta = 25^{\circ}C$			2	μΑ
Supply current at STOP	IDD6	$VDD = 3 V$, $Ta = -40^{\circ}C$ to $+85^{\circ}C$			8	μΑ

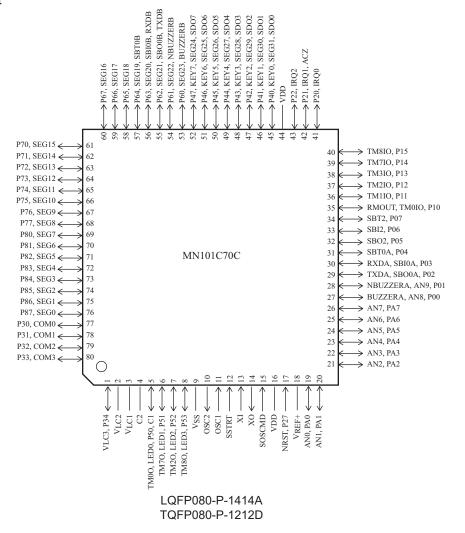
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Development tools

In-circuit Emulator

PX-ICE101C/D+PX-PRB101C70-LQFP080-P-1414A-M PX-ICE101C/D+PX-PRB101C70-TQFP080-P-1212-M

Pin Assignment



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